## Application/Control No. Applicant(s)/Patent Under Reexamination 10/762,654 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Jung Kim 2132 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,411,715 06-2002 Liskov et al. 380/277 Α US-В US-С US-D US-Ε F US-US-G US-Н US-US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.